Dual 2-Wide, 2-Input Expandable AND-OR-INVERT Gate

The MC14506UB is an expandable AND–OR–INVERT gate with inhibit and 3–state output. The expand option allows cascading with any other gate, which may be carried as far as desired as long as the propagation delay added with each gate is considered. For example, the second AOI gate in this device may be used to expand the first gate, giving an expanded 4–wide, 2–input AOI gate. This device is useful in data control and digital multiplexing applications.

- 3–State Output
- Separate Inhibit Line
- Diode Protection on All Inputs
- Supply Voltage Range = 3.0 Vdc to 18 Vdc
- Capable of Driving Two Low–Power TTL Loads or One Low–Power Schottky TTL Load Over the Rated Temperature Range

MAXIMUM RATINGS* (Voltages Referenced to V_{SS})

| Symbol	Parameter	Value	Unit
V_{DD}	DC Supply Voltage	− 0.5 to + 18.0	V
V_{in}, V_{out}	Input or Output Voltage (DC or Transient)	− 0.5 to V_{DD} + 0.5	V
I_{in}, I_{out}	Input or Output Current (DC or Transient), per Pin	± 10	mA
P_D	Power Dissipation, per Package†	500	mW
T_{stg}	Storage Temperature	− 65 to + 150	°C
T_L	Lead Temperature (8–Second Soldering)	260	°C

* Maximum Ratings are those values beyond which damage to the device may occur.
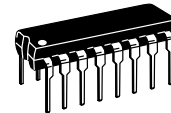†Temperature Derating:
    Plastic "P and D/DW" Packages: − 7.0 mW/°C From 65°C To 125°C
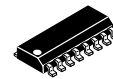   Ceramic "L" Packages: − 12 mW/°C From 100°C To 125°C

LOGIC DIAGRAM

V_{DD} = PIN 16
V_{SS} = PIN 8

$Z = \overline{(AB + CD + \overline{E} + I)}$

MC14506UB
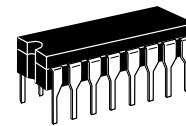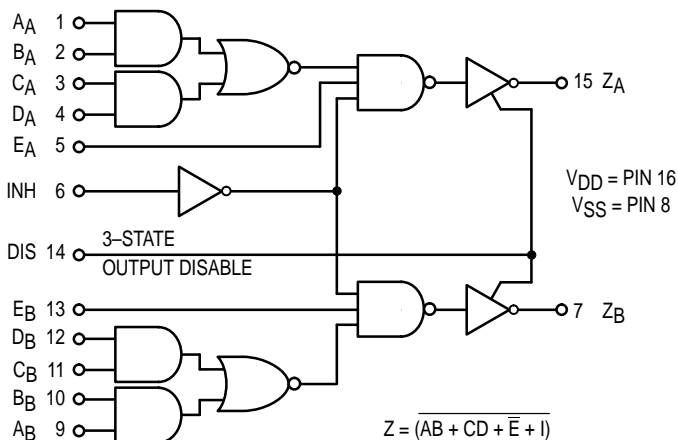
L SUFFIX
CERAMIC
CASE 620

P SUFFIX
PLASTIC
CASE 648

D SUFFIX
SOIC
CASE 751B

ORDERING INFORMATION

MC14XXXUBCP	Plastic
MC14XXXUBCL	Ceramic
MC14XXXUBD	SOIC

T_A = − 55° to 125°C for all packages.

TRUTH TABLE

A	B	C	D	E	Inhibit	Disable	Z
0	0	0	0	1	0	0	1
0	X	0	X	1	0	0	1
0	X	X	0	1	0	0	1
X	0	0	X	1	0	0	1
X	0	X	0	1	0	0	1
1	1	X	X	X	X	0	0
X	X	1	1	X	X	0	0
X	X	X	X	0	X	0	0
X	X	X	X	X	1	0	0
X	X	X	X	X	X	1	High Impedance

X = Don't Care

MOTOROLA

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

Characteristic	Symbol	V_{DD} Vdc	−55°C Min	−55°C Max	25°C Min	25°C Typ #	25°C Max	125°C Min	125°C Max	Unit
Output Voltage "0" Level V_{in} = V_{DD} or 0	V_{OL}	5.0	—	0.05	—	0	0.05	—	0.05	Vdc
		10	—	0.05	—	0	0.05	—	0.05	
		15	—	0.05	—	0	0.05	—	0.05	
"1" Level V_{in} = 0 or V_{DD}	V_{OH}	5.0	4.95	—	4.95	5.0	—	4.95	—	Vdc
		10	9.95	—	9.95	10	—	9.95	—	
		15	14.95	—	14.95	15	—	14.95	—	
Input Voltage "0" Level (V_O = 4.5 or 0.5 Vdc)	V_{IL}	5.0	—	1.0	—	2.25	1.0	—	1.0	Vdc
(V_O = 9.0 or 1.0 Vdc)		10	—	2.0	—	4.50	2.0	—	2.0	
(V_O = 13.5 or 1.5 Vdc)		15	—	2.5	—	6.75	2.5	—	2.5	
"1" Level (V_O = 0.5 or 4.5 Vdc)	V_{IH}	5.0	4.0	—	4.0	2.75	—	4.0	—	Vdc
(V_O = 1.0 or 9.0 Vdc)		10	8.0	—	8.0	5.50	—	8.0	—	
(V_O = 1.5 or 13.5 Vdc)		15	12.5	—	12.5	8.25	—	12.5	—	
Output Drive Current (V_{OH} = 2.5 Vdc) Source	I_{OH}	5.0	− 3.0	—	− 2.4	− 4.2	—	− 1.7	—	mAdc
(V_{OH} = 4.6 Vdc)		5.0	− 0.64	—	− 0.51	− 0.88	—	− 0.36	—	
(V_{OH} = 9.5 Vdc)		10	− 1.6	—	− 1.3	− 2.25	—	− 0.9	—	
(V_{OH} = 13.5 Vdc)		15	− 4.2	—	− 3.4	− 8.8	—	− 2.4	—	
(V_{OL} = 0.4 Vdc) Sink	I_{OL}	5.0	0.64	—	0.51	0.88	—	0.36	—	mAdc
(V_{OL} = 0.5 Vdc)		10	1.6	—	1.3	2.25	—	0.9	—	
(V_{OL} = 1.5 Vdc)		15	4.2	—	3.4	8.8	—	2.4	—	
Input Current	I_{in}	15	—	± 0.1	—	±0.00001	± 0.1	—	± 1.0	µAdc
Input Capacitance (V_{in} = 0)	C_{in}	—	—	—	—	5.0	7.5	—	—	pF
Quiescent Current (Per Package)	I_{DD}	5.0	—	1.0	—	0.002	1.0	—	30	µAdc
		10	—	2.0	—	0.004	2.0	—	60	
		15	—	4.0	—	0.006	4.0	—	120	
Total Supply Current**† (Dynamic plus Quiescent, Per Package) (C_L = 50 pF on all outputs, all buffers switching)	I_T	5.0	IT = (0.6 µA/kHz) f + I_{DD}							µAdc
		10	I_T = (1.1 µA/kHz) f + I_{DD}							
		15	I_T = (1.7 µA/kHz) f + I_{DD}							
Three–State Leakage Current	I_{TL}	15	—	± 0.1	—	± 0.0001	± 0.1	—	± 3.0	µAdc

\#Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.
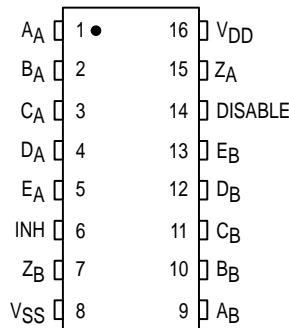
** The formulas given are for the typical characteristics only at 25°C.

†To calculate total supply current at loads other than 50 pF:

$$I_T(C_L) = I_T(50 \text{ pF}) + (C_L - 50) \text{ Vfk}$$

where: I_T is in µA (per package), C_L in pF, V = (V_{DD} − V_{SS}) in volts, f in kHz is input frequency, and k = 0.002.

PIN ASSIGNMENT

	Pin	Pin	
A_A	1 ●	16	V_{DD}
B_A	2	15	Z_A
C_A	3	14	DISABLE
D_A	4	13	E_B
E_A	5	12	D_B
INH	6	11	C_B
Z_B	7	10	B_B
V_{SS}	8	9	A_B

SWITCHING CHARACTERISTICS* (C_L = 50 pF, T_A = 25°C)

Characteristic	Symbol	V_{DD}	Min	Typ #	Max	Unit
Output Rise and Fall Time	t_{TLH}, t_{THL}					ns
t_{TLH}, t_{THL} = (1.5 ns/pF) C_L + 25 ns		5.0	—	100	200	
t_{TLH}, t_{THL} = (0.75 ns/pF) C_L + 12.5 ns		10	—	50	100	
t_{TLH}, t_{THL} = (0.55 ns/pF) C_L + 9.5 ns		15	—	40	80	
Data Propagation Delay Time	t_{PLH}					ns
t_{PLH} = (1.7 ns/pF) C_L + 210 ns		5.0	—	295	580	
t_{PLH} = (0.66 ns/pF) C_L + 77 ns		10	—	110	225	
t_{PLH} = (0.5 ns/pF) C_L + 50 ns		15	—	75	180	
t_{PHL} = (1.7 ns/pF) C_L + 185 ns	t_{PHL}	5.0	—	270	480	ns
t_{PHL} = (0.66 ns/pF) C_L + 62 ns		10	—	95	175	
t_{PHL} = (0.5 ns/pF) C_L + 40 ns		15	—	65	140	
Expand Propagation Delay Time	t_{PLH}					ns
t_{PLH} = (1.7 ns/pF) C_L + 95 ns		5.0	—	180	430	
t_{PLH} = (0.66 ns/pF) C_L + 42 ns		10	—	75	160	
t_{PLH} = (0.5 ns/pF) C_L + 25 ns		15	—	50	125	
t_{PHL} = (1.7 ns/pF) C_L + 115 ns	t_{PHL}	5.0	—	200	330	ns
t_{PHL} = (0.66 ns/pF) C_L + 47 ns		10	—	80	110	
t_{PHL} = (0.5 ns/pF) C_L + 30 ns		15	—	55	90	
Inhibit Propagation Delay Time	t_{PLH}					ns
t_{PLH} = (1.7 ns/pF) C_L + 135 ns		5.0	—	220	500	
t_{PLH} = (0.66 ns/pF) C_L + 67 ns		10	—	100	225	
t_{PLH} = (0.5 ns/pF) C_L + 40 ns		15	—	65	160	
t_{PHL} = (1.7 ns/pF) C_L + 145 ns	t_{PHL}	5.0	—	230	400	ns
t_{PHL} = (0.66 ns/pF) C_L + 62 ns		10	—	95	175	
t_{PHL} = (0.5 ns/pF) C_L + 35 ns		15	—	60	150	
3–State Propagation Delay Time	t_{PHZ}					ns
"1" to High Impedance		5.0	—	60	150	
		10	—	45	110	
		15	—	35	90	
"0" to High Impedance	t_{PLZ}	5.0	—	90	225	ns
		10	—	55	140	
		15	—	40	100	
High Impedance to "1"	t_{PZH}	5.0	—	110	300	ns
		10	—	50	125	
		15	—	40	100	
High Impedance to "0"	t_{PZL}	5.0	—	170	425	ns
		10	—	70	175	
		15	—	50	125	

* The formulas given are for the typical characteristics only at 25°C.
#Data labelled "Typ" Is not to be used for design purposes but is intended as an indication of the IC's potential performance.
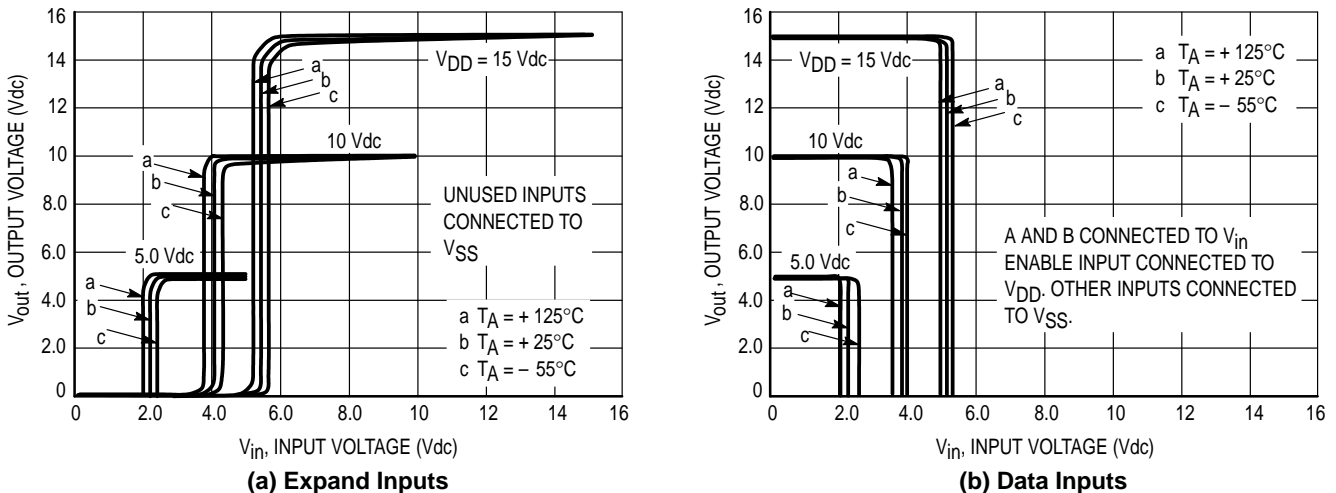

(a) Expand Inputs

(b) Data Inputs

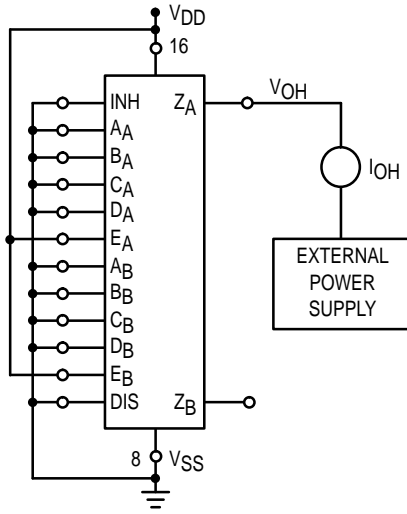**Figure 1. Typical Voltage Transfer Characteristics**

**Figure 2. Typical Output Source
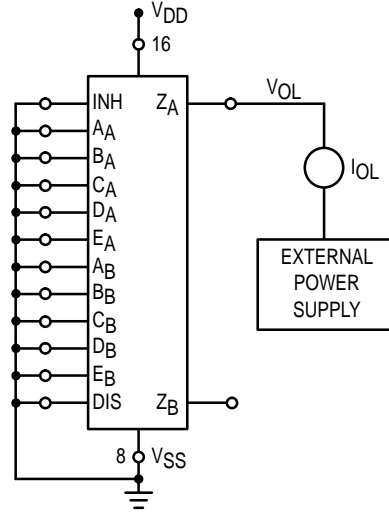Characteristics Test Circuit**

**Figure 3. Typical Output Sink
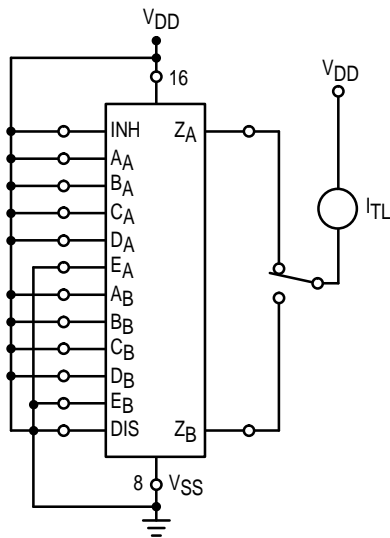Characteristics Test Circuit**

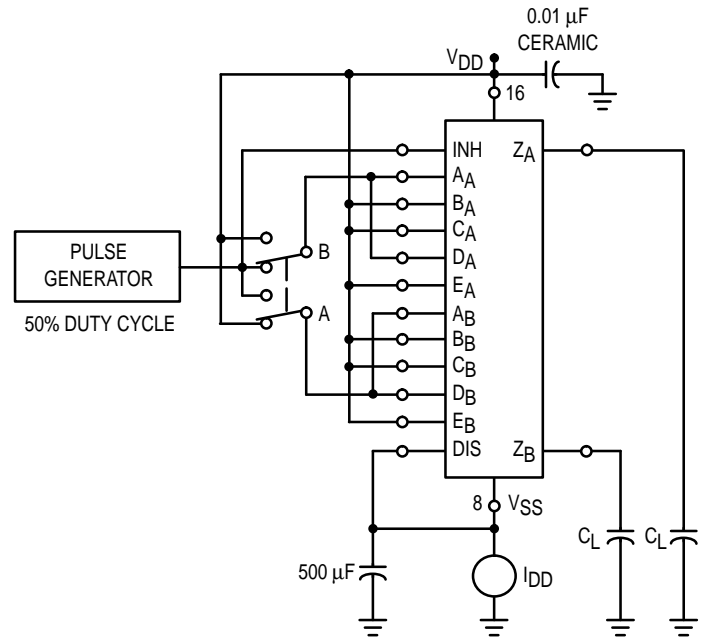**Figure 4. 3–State Leakage Current
Test Circuit**

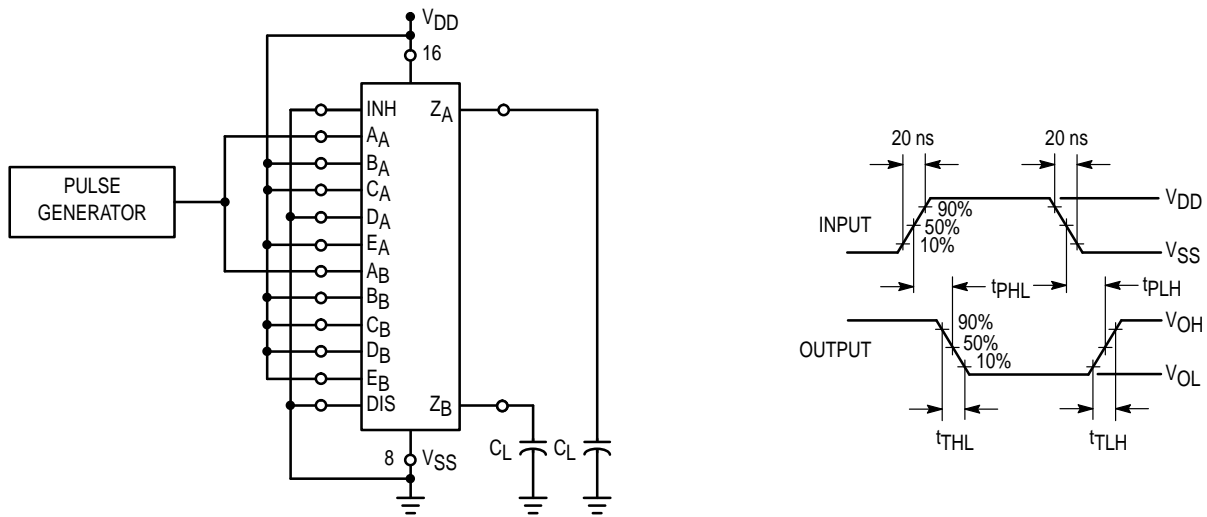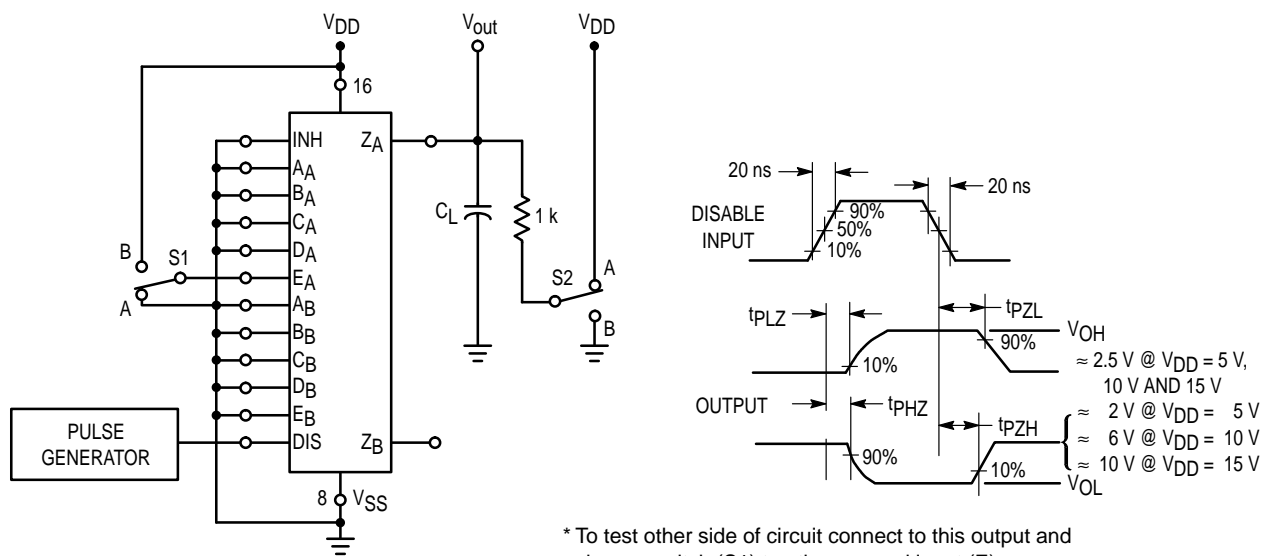**Figure 5. Typical Power Dissipation
Test Circuit**

**Figure 6. Switching Time Test Circuit and Waveforms
(Data Inputs)**

* To test other side of circuit connect to this output and
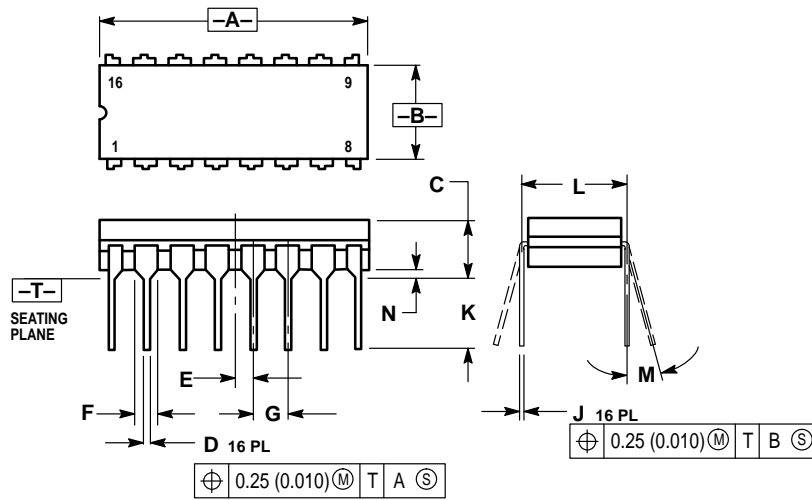change switch (S1) to other expand input (E).

SWITCH POSITIONS

TEST	S1	S2
t_{PLZ}	A	A
t_{PHZ}	B	B
t_{PZL}	A	A
t_{PZH}	B	B

**Figure 7. Switching Time Test Circuit and Waveforms
(For 3–State Output)**

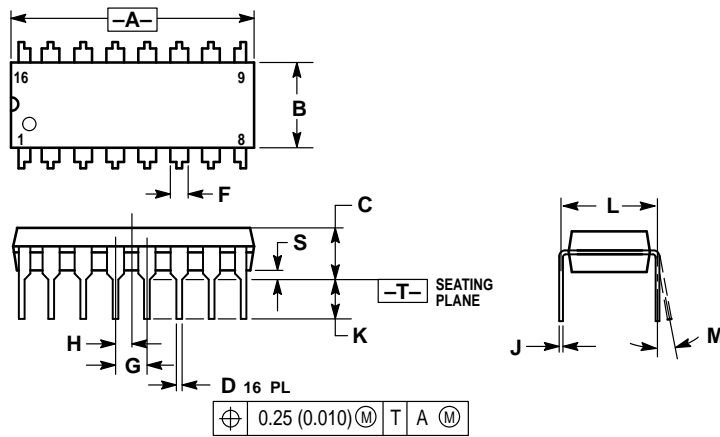## OUTLINE DIMENSIONS

L SUFFIX
CERAMIC DIP PACKAGE
CASE 620–10
ISSUE V

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
4. DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.750	0.785	19.05	19.93
B	0.240	0.295	6.10	7.49
C	——	0.200	——	5.08
D	0.015	0.020	0.39	0.50
E	0.050 BSC		1.27 BSC	
F	0.055	0.065	1.40	1.65
G	0.100 BSC		2.54 BSC	
H	0.008	0.015	0.21	0.38
K	0.125	0.170	3.18	4.31
L	0.300 BSC		7.62 BSC	
M	0 °	15 °	0 °	15 °
N	0.020	0.040	0.51	1.01

P SUFFIX
PLASTIC DIP PACKAGE
CASE 648–08
ISSUE R

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100 BSC		2.54 BSC	
H	0.050 BSC		1.27 BSC	
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0 °	10 °	0 °	10 °
S	0.020	0.040	0.51	1.01

OUTLINE DIMENSIONS

D SUFFIX
PLASTIC SOIC PACKAGE
CASE 751B–05
ISSUE J
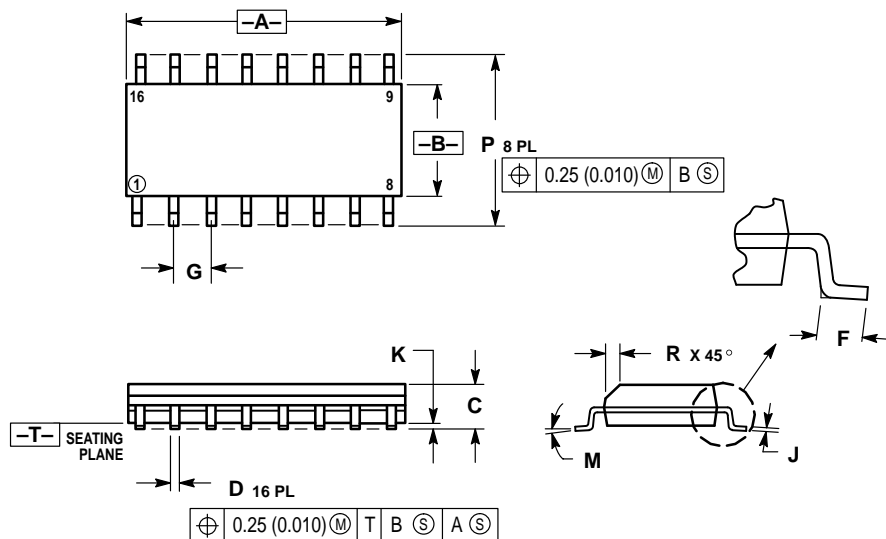
NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	9.80	10.00	0.386	0.393
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27 BSC		0.050 BSC	
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0 °	7 °	0 °	7 °
P	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

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INTERNET: http://Design–NET.com

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ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298

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MC14506UB/D